Search Notes					

_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/655,900	SHIUE ET AL.	
	Examiner	Art Unit	
	Sayed T. Zewari	2687	

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	575.300	1/20/2006	STZ
455	575.300	1/20/2006	STZ
455	575.8	1/20/2006	STZ
455	550.1	1/23/2006	STZ
455	90.3	1/23/2006	STZ
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Nick Corsaro		1/20/2006	STZ
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